STD3N40K3

N-channel 400 V, 2.7 Ω typ., 2 A SuperMESH3™ Zener-protected Power MOSFET in a DPAK package

Datasheet — production data

Features

Order code	V$_{DSS}$	R$_{DS(on)}$ max	I$_D$	Pw
STD3N40K3	400 V	< 3.4 Ω	2 A	30 W

■ 100% avalanche tested

■ Extremely high dv/dt capability

■ Gate charge minimized

■ Very low intrinsic capacitance

■ Improved diode reverse recovery characteristics

■ Zener-protected

Applications

■ Switching applications

Description

This SuperMESH3™ Power MOSFET is the result of improvements applied to STMicroelectronics' SuperMESH™ technology, combined with a new optimized vertical structure. This device boasts an extremely low on-resistance, superior dynamic performance and high avalanche capability, rendering it suitable for the most demanding applications.
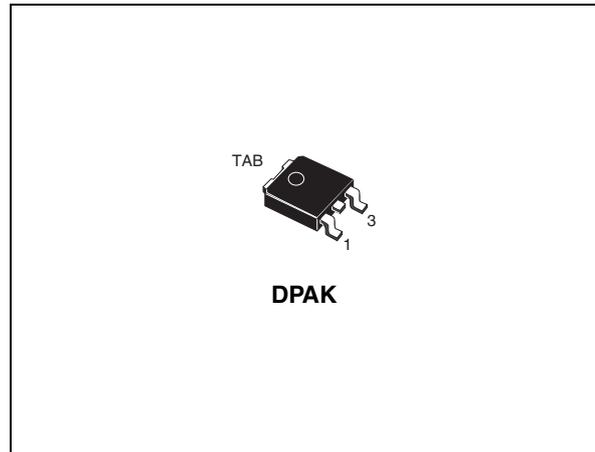

**DPAK**

Figure 1. Internal schematic diagram
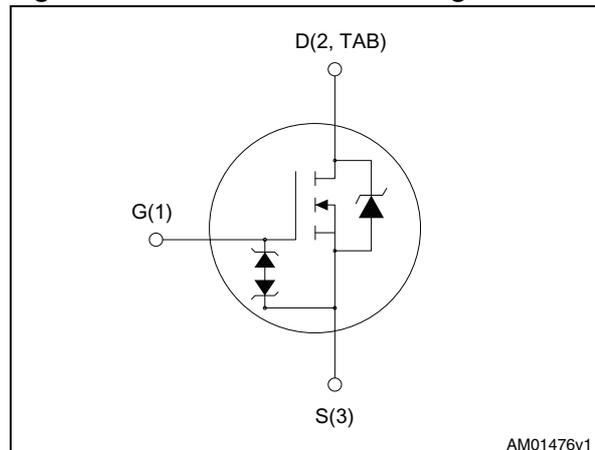
Table 1. Device summary

Order code	Marking	Package	Packaging
STD3N40K3	3N40K3	DPAK	Tape and reel

Contents

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-source voltage	400	V
V_{GS}	Gate- source voltage	± 30	V
I_D	Drain current (continuous) at T_C = 25 °C	2	A
I_D	Drain current (continuous) at T_C = 100 °C	1.2	A
I_{DM} [1]	Drain current (pulsed)	8.0	A
P_{TOT}	Total dissipation at T_C = 25 °C	30	W
I_{AR}	Avalanche current, repetitive or not-repetitive (pulse width limited by T_j max)	1	A
E_{AS}	Single pulse avalanche energy (starting T_j = 25°C, I_D = I_{AR}, V_{DD} = 50 V)	45	mJ
$V_{ESD(G-S)}$	Gate source ESD(HBM-C = 100 pF, R = 1.5 kΩ)	2500	V
dv/dt [2]	Peak diode recovery voltage slope	12	V/ns
T_{stg}	Storage temperature	- 55 to 150	°C
T_j	Max. operating junction temperature		°C

1. Pulse width limited by safe operating area.

2. I_{SD} < 2 A, di/dt = 400 A/µs, V_{DD} = 80% $V_{(BR)DSS}$, VDS peak ≤ $V_{(BR)DSS}$.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case max	4.17	°C/W
$R_{thj-pcb}$	Thermal resistance junction-pcb max	50	°C/W

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 4.   On /off states

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	I_D = 1 mA, V_{GS} = 0	400			V
I_{DSS}	Zero gate voltage drain current (V_{GS} = 0)	V_{DS} = 400 V V_{DS} = 400 V, T_C=125 °C			1 50	µA µA
I_{GSS}	Gate-body leakage current (V_{DS} = 0)	V_{GS} = ± 20 V, V_{DS}=0			±10	µA
$V_{GS(th)}$	Gate threshold voltage	V_{GS} = V_{DS}, I_D = 50 µA	3	3.75	4.5	V
$R_{DS(on)}$	Static drain-source on-resistance	V_{GS} = 10 V, I_D = 0.9 A		2.7	3.4	Ω

Table 5.   Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{iss} C_{oss} C_{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V_{DS} = 50 V, f = 1 MHz, V_{GS} = 0	-	165 17 3	-	pF pF pF
$C_{oss(er)}$[1]	Equivalent output capacitance energy related	V_{DS}=0 to 320 V, V_{GS}=0	-	9	-	pF
$C_{oss(tr)}$[2]	Equivalent output capacitance time related		-	14	-	pF
R_g	Instrinsic gate resistance	f=1 MHz open drain	-	10	-	Ω
Q_g Q_{gs} Q_{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} = 320 V, I_D = 1.8 A, V_{GS} = 10 V (see *Figure 16*)	-	11 2 7	-	nC nC nC

1. Is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

2. Is defined as a constant equivalent capacitance giving the same storage energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 6. **Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn on delay time	V_{DD} = 200 V, I_D = 0.6, R_G = 4.7 Ω, V_{GS} = 10 V (see *Figure 15*)	-	7	-	ns
t_r	Rise time			8		ns
$t_{d(off)}$	Turn off delay time			18		ns
t_f	Fall time			14		ns

Table 7. **Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
I_{SD} I_{SDM} [1]	Source-drain current Source-drain current (pulsed)		-		1.8 7.2	A A
V_{SD} [2]	Forward on voltage	I_{SD} = 1.8 A, V_{GS} = 0	-		1.5	V
t_{rr} Q_{rr} I_{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 1.8 A, di/dt = 100 A/μs V_{DD} = 60 V (see *Figure 17*)	-	145 490 7		ns nC A
t_{rr} Q_{rr} I_{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 1.8 A, di/dt = 100 A/μs V_{DD} = 60 V, T_j = 150 °C (see *Figure 17*)	-	166 580 7		ns nC A

1. Pulse width limited by safe operating area.

2. Pulsed: pulse duration = 300 μs, duty cycle 1.5%

Table 8. **Gate-source Zener diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
BV_{GSO}	Gate-source breakdown voltage	Igs=± 1 mA (open drain)	30	-		V

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area
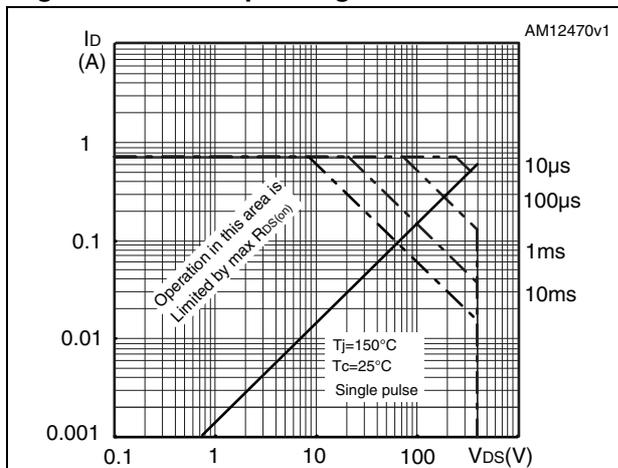

Figure 3. Thermal impedance
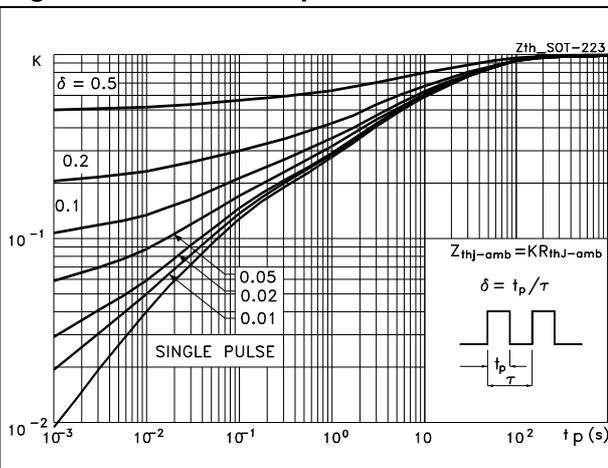
**Figure 4. Output characteristics**
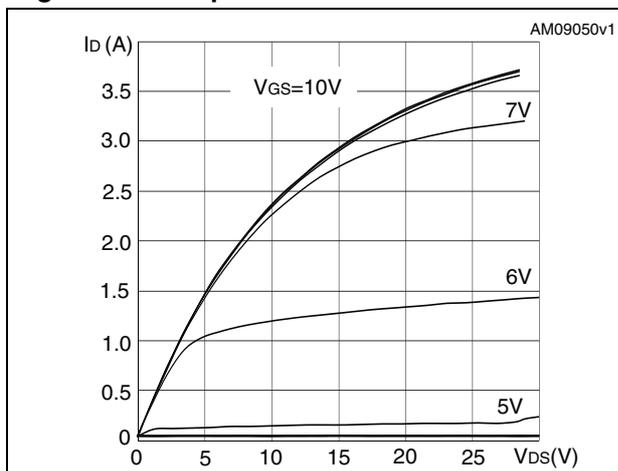


Figure 5. Transfer characteristics
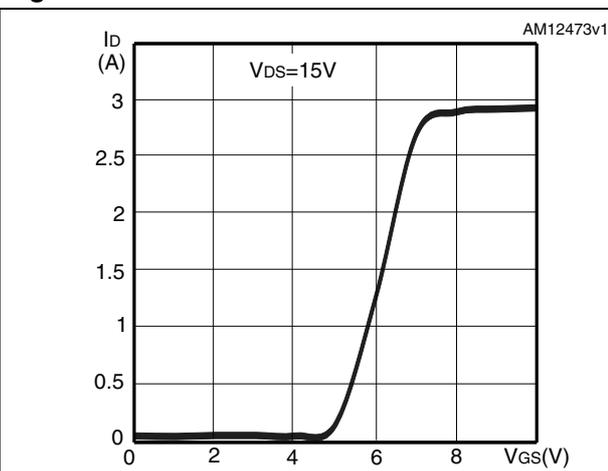
**Figure 6. Gate charge vs gate-source voltage**
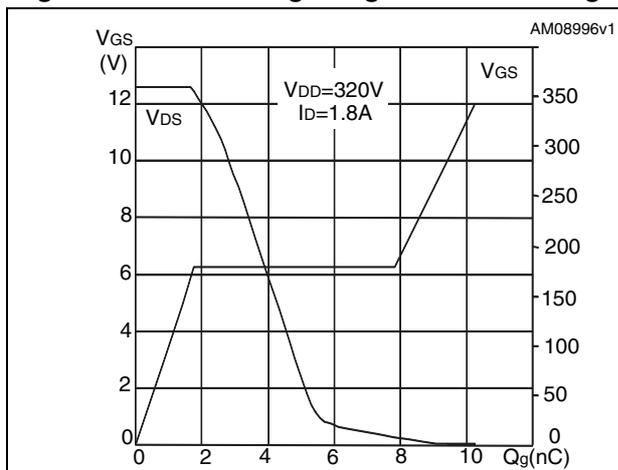
**Figure 7. Static drain-source on-resistance**
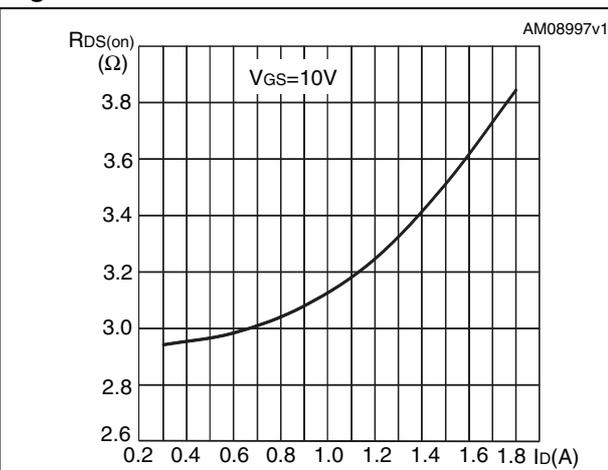
Figure 8. **Capacitance variations**
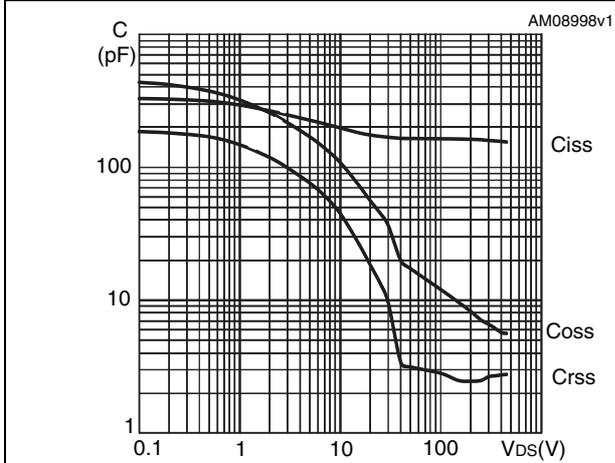
Figure 9. **Output capacitance stored energy**
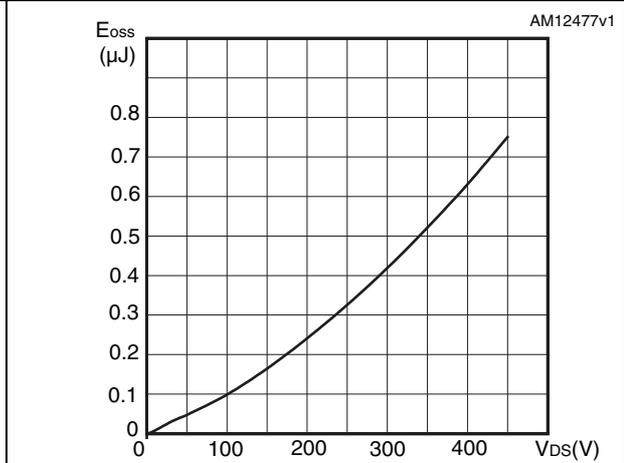
Figure 10. **Normalized gate threshold voltage vs. temperature**
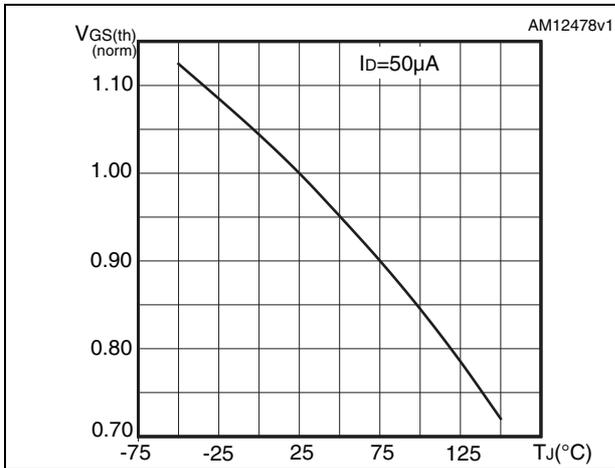

**Figure 11.** **Normalized on-resistance vs. temperature**
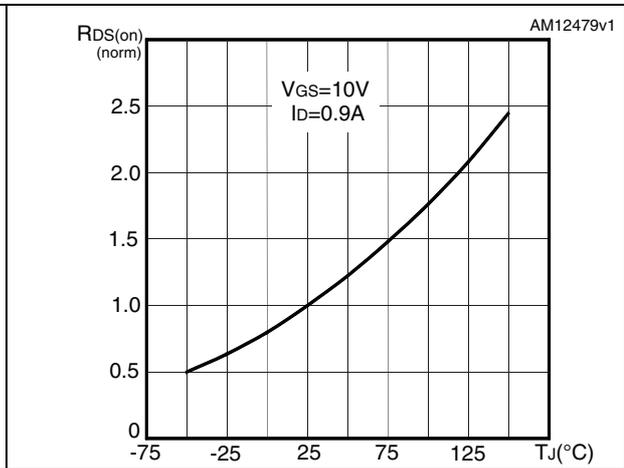
**Figure 12.** **Source-drain diode forward characteristics**
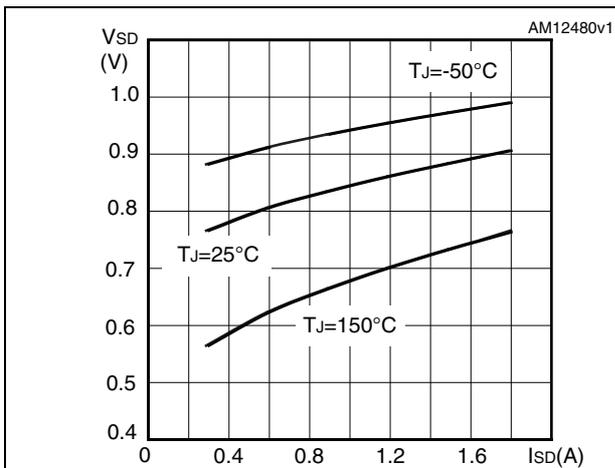
**Figure 13.** **Normalized BV_{DSS} vs. temperature**
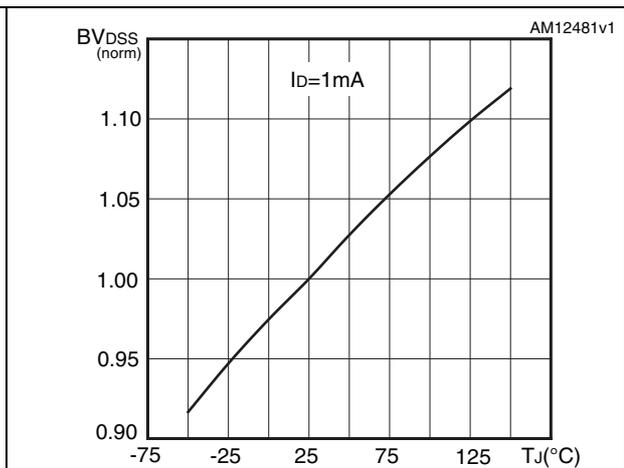
**Figure 14. Maximum avalanche energy vs.
starting Tj**
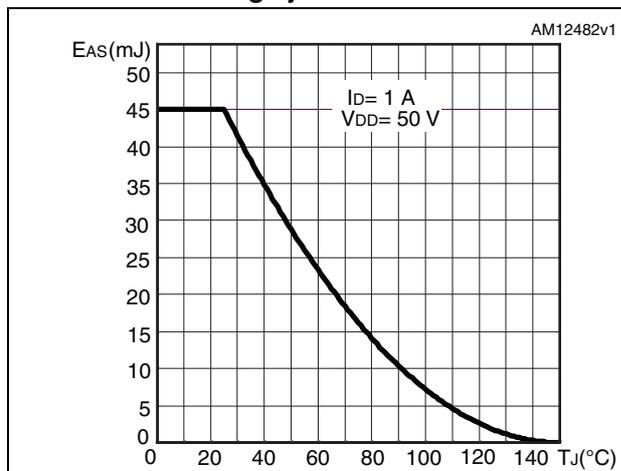
3   Test circuits

**Figure 15.   Switching times test circuit for resistive load**
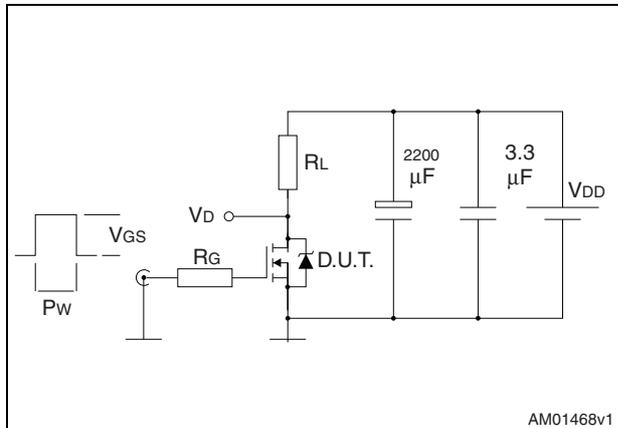
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**Figure 16.   Gate charge test circuit**
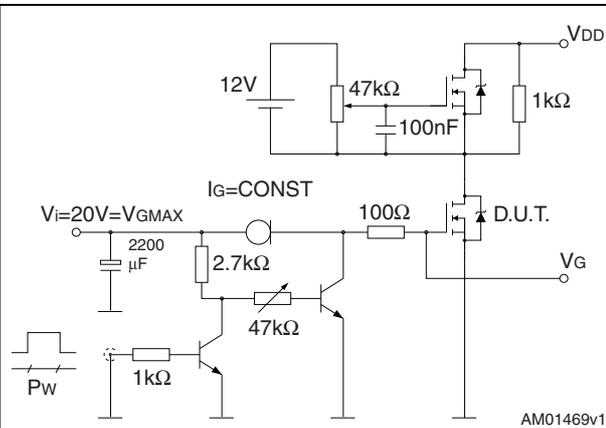
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Figure 17.   Test circuit for inductive load switching and diode recovery times
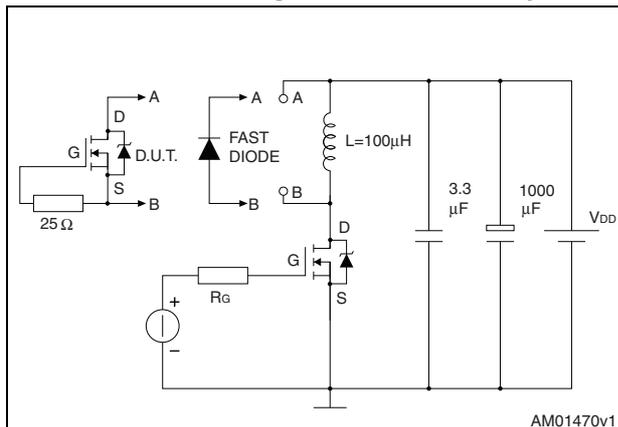
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Figure 18.   Unclamped Inductive load test circuit
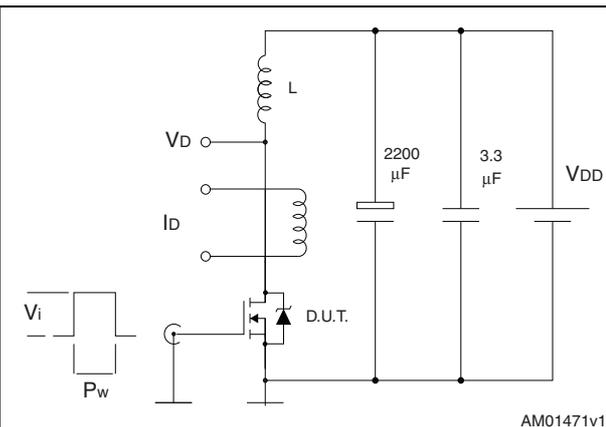
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Figure 19.   Unclamped inductive waveform
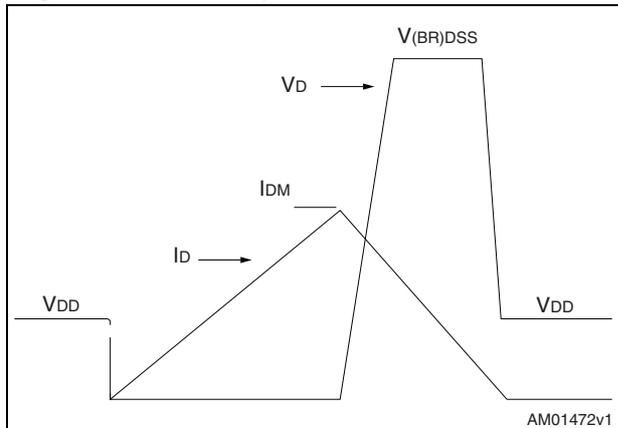
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Figure 20.   Switching time waveform
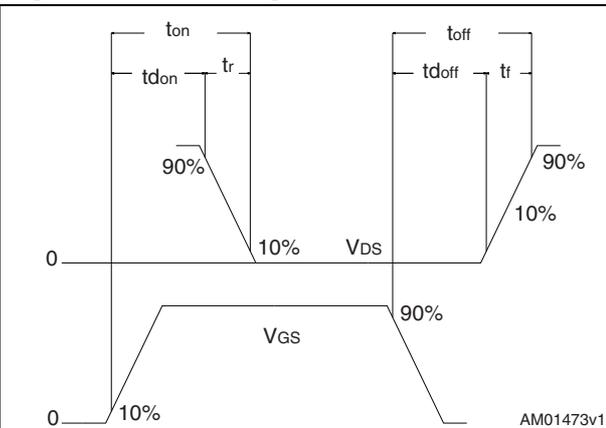
AM01473v1

4 Package mechanical data

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Table 9.   DPAK (TO-252) mechanical data

Dim.	mm		
	Min.	**Typ.**	**Max.**
A	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
c	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
E	6.40		6.60
E1		4.70	
e		2.28	
e1	4.40		4.60
H	9.35		10.10
L	1		1.50
L1		2.80	
L2		0.80	
L4	0.60		1
R		0.20	
V2	0°		8°

Figure 21.   DPAK (TO-252) drawing
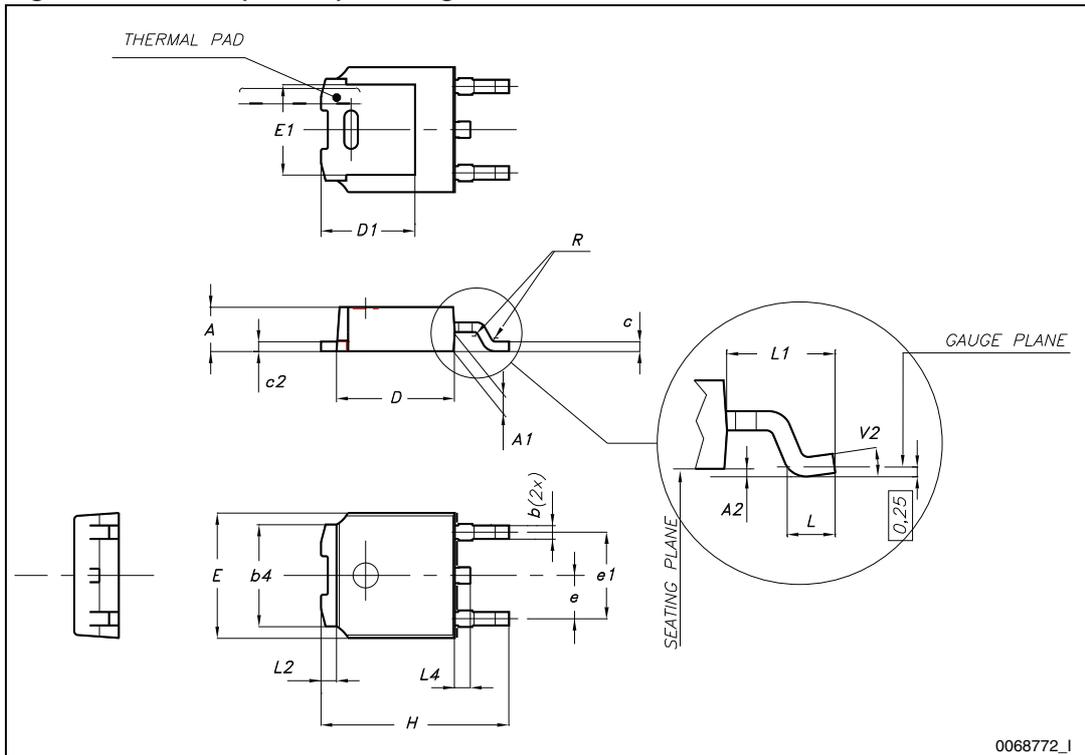

Figure 22.   DPAK footprint[a]

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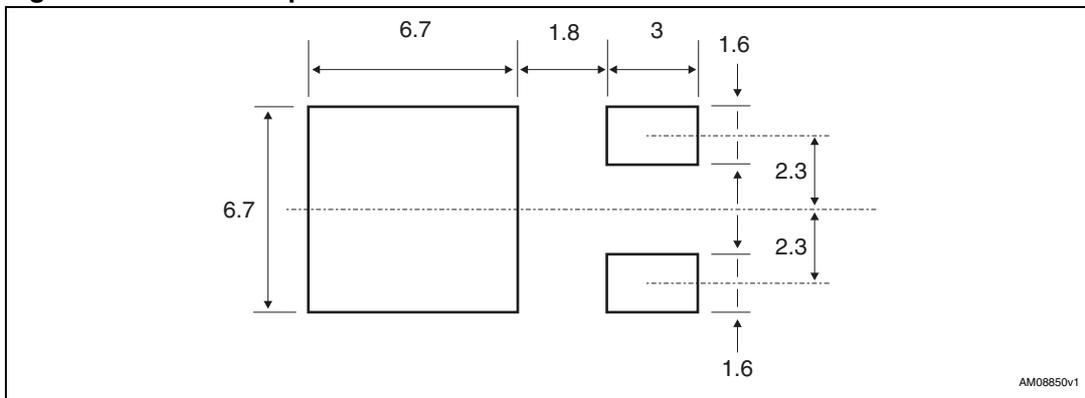
a.   All dimension are in millimeters

5 Packaging mechanical data

Table 10.   DPAK (TO-252) tape and reel mechanical data

Tape			Reel		
Dim.	**mm**		**Dim.**	**mm**	
	Min.	**Max.**		**Min.**	**Max.**
A0	6.8	7	A		330
B0	10.4	10.6	B	1.5	
B1		12.1	C	12.8	13.2
D	1.5	1.6	D	20.2	
D1	1.5		G	16.4	18.4
E	1.65	1.85	N	50	
F	7.4	7.6	T		22.4
K0	2.55	2.75			
P0	3.9	4.1	Base qty.		2500
P1	7.9	8.1	Bulk qty.		2500
P2	1.9	2.1			
R	40				
T	0.25	0.35			
W	15.7	16.3			

Figure 23. Tape for DPAK (TO-252)
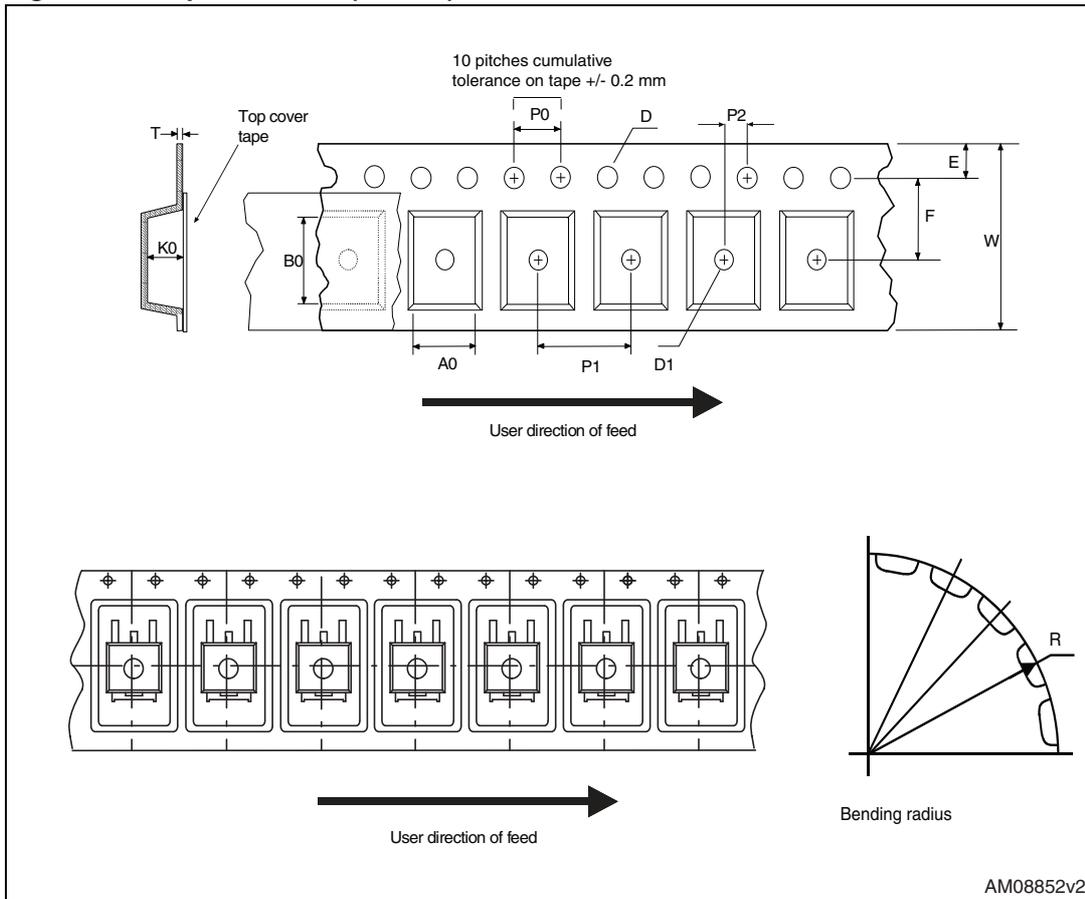
Figure 24. Reel for DPAK (TO-252)
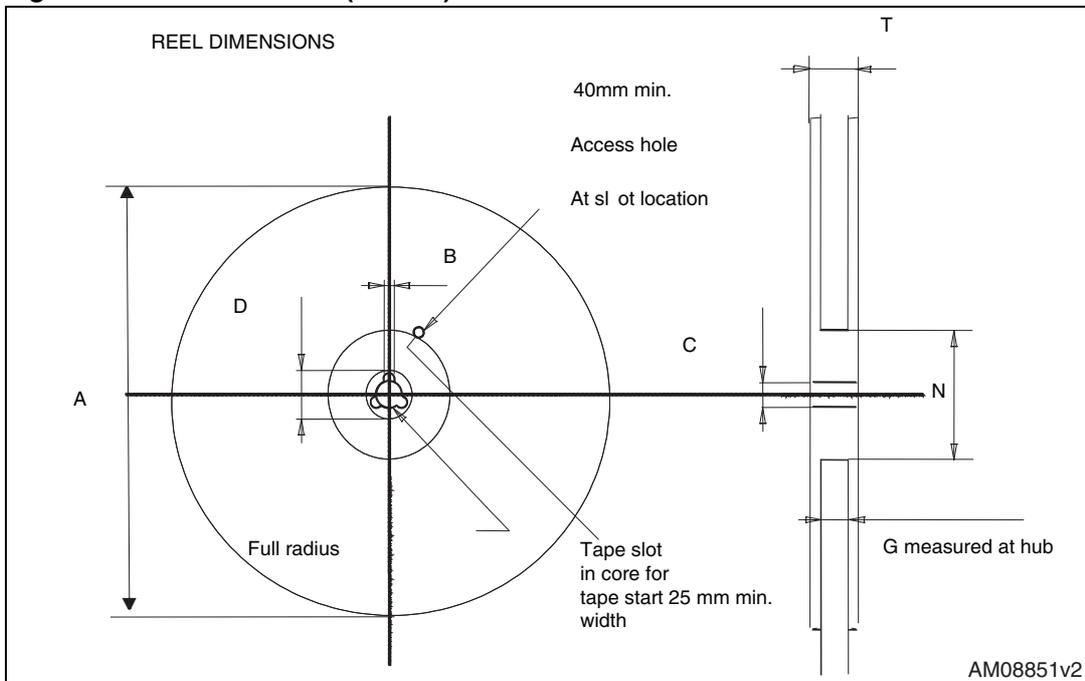
6 Revision history

Table 11. Document revision history

Date	Revision	Changes
24-Jul-2012	1	First release.

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